## Notice of References Cited Application/Control No. 10/625,909 Examiner Justin Y. Lee Applicant(s)/Patent Under Reexamination STURA ET AL. Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0068545	06-2002	Oyama et al.	455/406
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